## Notice of References Cited Application/Control No. 10/591,744 Examiner JAE KWAK Applicant(s)/Patent Under Reexamination NEFFGEN ET AL. Art Unit 1796 Page 1 of 1

## U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-6,462,100 B1	10-2002	Thunhorst et al.	521/53
*	В	US-6,688,494 B2	02-2004	Pozarnsky et al.	222/4
*	C	US-2004/0029980 A1	02-2004	Stumphauzer et al.	516/31
*	D	US-2004/0079258 A1	04-2004	Hoescheler et al.	106/035
*	Е	US-6,730,156 B1	05-2004	Windisch et al.	106/35
*	F	US-6,890,968 B2	05-2005	Angeletakis et al.	523/115
*	G	US-6,936,642 B2	08-2005	Lehmann et al.	523/115
*	Ι	US-2005/0203227 A1	09-2005	Kuhnle et al.	524/261
*	I	US-7,153,357 B2	12-2006	Baumgart et al.	106/481
	J	US-			
	K	US-			
	L	US-			
	М	US-			

## FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	Ν	EP 1149573 A2	10-2001	European Patent	TERAMAE et al.	
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## **NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.